

8-BIT UNIVERSAL BUS TRANSCEIVER AND TWO 1-BIT BUS TRANSCEIVERS WITH SPLIT LVTTL PORT, FEEDBACK PATH, AND 3-STATE OUTPUTS

Check for Samples: SN74VMEH22501A

¹FEATURES

- **• Member of the Texas Instruments Widebus™ • ESD Protection Exceeds JESD 22 Family – 2000-V Human-Body Model (A114-A)**
- **• UBT™ Transceiver Combines D-Type Latches – 200-V Machine Model (A115-A) and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Modes**
- **• OEC™ Circuitry Improves Signal Integrity and DGG OR DGV PACKAGE Reduces Electromagnetic Interference (EMI)**
- **• Compliant With VME64, 2eVME, and 2eSST Protocols**
- **• Bus Transceiver Split LVTTL Port Provides a Feedback Path for Control and Diagnostics Monitoring**
- **• I/O Interfaces Are 5-V Tolerant**
- **• B-Port Outputs (–48 mA/64 mA)**
- **• Y and A-Port Outputs (–12 mA/12 mA)**
- **l**_{off}, Power-Up 3-State, and BIAS V_{CC} Support **Live Insertion**
- **• Bus Hold on 3A-Port Data Inputs**
- **• 26-Ω Equivalent Series Resistor on 3A Ports and Y Outputs**
- **• Flow-Through Architecture Facilitates Printed Circuit Board Layout**
- **•** Distributed V_{CC} and GND Pins Minimize **High-Speed Switching Noise**
- **• Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II**
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	-
	- **– 1000-V Charged-Device Model (C101)**

DESCRIPTION/ORDERING INFORMATION

The SN74VMEH22501A 8-bit universal bus transceiver has two integral 1-bit three-wire bus transceivers and is designed for 3.3-V V_{CC} operation with 5-V tolerant inputs. The UBT[™] transceiver allows transparent, latched, and flip-flop modes of data transfer, and the separate LVTTL input and outputs on the bus transceivers provide a feedback path for control and diagnostics monitoring. This device provides a high-speed interface between cards operating at LVTTL logic levels and VME64, VME64x, or VME320(1) backplane topologies.

The SN74VMEH22501A is pin-for-pin capatible to the SN74VMEH22501 (TI literature number SCES357), but operates at a wider operating temperature (−40°C to 85°C) range.

(1) VME320 is a patented backplane construction by Arizona Digital, Inc.

DESCRIPTION/ORDERING INFORMATION (CONTINUED)

All inputs and outputs are 5-V tolerant and are compatible with TTL and 5-V CMOS inputs.

and, possibly, 1-Gbyte transfer rates on the VME320 backplane.

provided on 1A or 2A inputs, any B-port input, or any control input. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

This device is fully specified for live-insertion applications using I_{off} , power-up 3-state, and BIAS V_{CC}. The I_{off} circuitry prevents damaging current to backflow through the device when it is powered off/on. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict. The BIAS V_{CC} circuitry precharges and preconditions the B-port input/output connections, preventing disturbance of active data on the backplane during card insertion or removal, and permits true live-insertion capability.

Active bus-hold circuitry holds unused or undriven 3A-port inputs at a valid logic state. Bus-hold circuitry is not

High-speed backplane operation is a direct result of the improved OEC™ circuitry and high drive that has been designed and tested into the VME64x backplane model. The B-port I/Os are optimized for driving large capacitive loads and include pseudo-ETL input thresholds ($\frac{1}{2}$ V_{CC} \pm 50 mV) for increased noise immunity. These specifications support the 2eVME protocols in VME64x (ANSI/VITA 1.1) and 2eSST protocols in VITA 1.5. With proper design of a 21-slot VME system, a designer can achieve 320-Mbyte transfer rates on linear backplanes

When V_{CC} is between 0 and 1.5 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, output-enable (OE and OEBY) inputs should be tied to V_{CC} through a pullup resistor and output-enable (OEAB) inputs should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the drive capability of the device connected to this input.

ORDERING INFORMATION

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/sc/packaging.

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www.ti.com SCES3620A –DECEMBER 2004–REVISED FEBRUARY 2010

TERMINAL ASSIGNMENTS(1)

(1) NC - No internal connection

FUNCTIONAL DESCRIPTION

The SN74VMEH22501A is a high-drive (–48/64 mA), 8-bit UBT transceiver containing D-type latches and D-type flip-flops for data-path operation in transparent, latched, or flip-flop modes. Data transmission is true logic. The device is uniquely partitioned as 8-bit UBT transceivers with two integrated 1-bit three-wire bus transceivers.

Functional Description for Two 1-Bit Bus Transceivers

The OEAB inputs control the activity of the 1B or 2B port. When OEAB is high, the B-port outputs are active. When OEAB is low, the B-port outputs are disabled.

Separate 1A and 2A inputs and 1Y and 2Y outputs provide a feedback path for control and diagnostics monitoring. The OEBY inputs control the 1Y or 2Y outputs. When OEBY is low, the Y outputs are active. When OEBY is high, the Y outputs are disabled.

The OEBY and OEAB inputs can be tied together to form a simple direction control where an input high yields A data to B bus and an input low yields B data to Y bus.

1-BIT BUS TRANSCEIVER FUNCTION TABLE

Functional Description for 8-Bit UBT Transceiver

The 3A and 3B data flow in each direction is controlled by the \overline{OE} and direction-control (DIR) inputs. When \overline{OE} is low, all 3A- or 3B-port outputs are active. When \overline{OE} is high, all 3A- or 3B-port outputs are in the high-impedance state.

FUNCTION TABLE

The UBT transceiver functions are controlled by latch-enable (LE) and clock (CLKAB and CLKBA) inputs. For 3A-to-3B data flow, the UBT operates in the transparent mode when LE is high. When LE is low, the 3A data is latched if CLKAB is held at a high or low logic level. If LE is low, the 3A data is stored in the latch/flip-flop on the low-to-high transition of CLKAB.

The UBT transceiver data flow for 3B to 3A is similar to that of 3A to 3B, but uses CLKBA.

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Table 1. UBT TRANSCEIVER FUNCTION TABLE(1)

(1) 3A-to-3B data flow is shown; 3B-to-3A data flow is similar, but uses CLKBA.

(2) Output level before the indicated steady-state input conditions were established, provided that CLKAB was high before LE went low

(3) Output level before the indicated steady-state input conditions were established

The UBT transceiver can replace any of the functions shown in Table 2.

Table 2. SN74VMEH22501A UBT Transceiver Replacement Functions

Pin numbers shown are for the DGG and DGV packages.

Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(3) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions(1) (2)

(1) All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

(2) Proper connection sequence for use of the B-port I/O precharge feature is GND and BIAS $V_{CC} = 3.3$ V first, I/O second, and $V_{CC} = 3.3$ V last, because the BIAS V_{CC} precharge circuitry is disabled when any V_{CC} pin is connected. The control inputs can be connected at any time, but normally are connected during the I/O stage. If B-port precharge is not required, any connection sequence is acceptable, but generally, GND is connected first.

Electrical Characteristics

over recommended operating free-air temperature range for A and B ports (unless otherwise noted)

(1) All typical values are at $V_{CC} = 3.3$ V, $T_A = 25^{\circ}C$.
(2) For I/O ports, the parameters I_{OZH} and I_{OZL} inclu

For I/O ports, the parameters I_{OZH} and I_{OZL} include the input leakage current.

(3) The bus-hold circuit can sink at least the minimum low sustaining current at V_{IL} max. I_{BHL} should be measured after lowering V_{IN} to GND, then raising it to V_{IL} max.

(4) The bus-hold circuit can source at least the minimum high sustaining current at V_{IH} min. I_{BHH} should be measured after raising V_{IN} to V_{CC} , then lowering it to V_{IH} min.

(5) An external driver must source at least I_{BHLO} to switch this node from low to high.
(6) An external driver must sink at least I_{BHLO} to switch this node from high to low.

(6) An external driver must sink at least I_{BHHO} to switch this node from high to low.
(7) High-impedance state during power up or power down

High-impedance state during power up or power down

(8) This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

Electrical Characteristics (continued)

over recommended operating free-air temperature range for A and B ports (unless otherwise noted)

Live-Insertion Specifications

over recommended operating free-air temperature range for B port

(1) All typical values are at $V_{CC} = 3.3 V$, $T_A = 25^{\circ}C$.

(2) $V_{CC} - 0.5 V < BIAS V_{CC}$

Timing Requirements for UBT Transceiver

over recommended operating conditions (unless otherwise noted) (see Figure 1 and Figure 2)

Texas **INSTRUMENTS**

Switching Characteristics for Bus Transceiver Function

over recommended operating conditions (unless otherwise noted) (see Figure 1 and Figure 2)

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Switching Characteristics for UBT Transceiver

over recommended operating conditions (unless otherwise noted) (see Figure 1 and Figure 2)

Skew Characteristics for Bus Transceiver

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 1 and Figure 2)

 (t) $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) $[t_{sk(t)}]$.

Skew Characteristics for UBT

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 1 and Figure 2)

(1) $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) $[t_{sk(t)}]$.

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PARAMETER MEASUREMENT INFORMATION

NOTES: $A. C_L$ includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR ≈ 10 MHz, Z_O = 50 Ω , t_r ≈ 2 ns, t_f ≈ 2 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR ≈ 10 MHz, $Z_O = 50 \Omega$, $t_r \approx 2$ ns, $t_f \approx 2$ ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms

INSTRUMENTS

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Distributed-Load Backplane Switching Characteristics

The preceding switching characteristics tables show the switching characteristics of the device into the lumped load shown in the parameter measurement information (PMI) (see Figure 1 and Figure 2). All logic devices currently are tested into this type of load. However, the designer's backplane application probably is a distributed load. For this reason, this device has been designed for optimum performance in the VME64x backplane as shown in Figure 3.

 \dagger Unloaded backplane trace natural impedence (Z_O) is 45 Ω. 45 Ω to 60 Ω is allowed, with 50 Ω being ideal. \ddagger Card stub natural impedence (Z_O) is 60 Ω.

Figure 3. VME64x Backplane

The following switching characteristics tables derived from TI-SPICE models show the switching characteristics of the device into the backplane under full and minimum loading conditions, to help the designer better understand the performance of the VME device in this typical backplane. See www.ti.com/sc/etl for more information.

Driver in Slot 11, With Receiver Cards in All Other Slots (Full Load)

Switching Characteristics for Bus Transceiver Function

over recommended operating conditions (unless otherwise noted) (see Figure 3)

(1) All typical values are at $V_{CC} = 3.3 V$, $T_A = 25°C$. All values are derived from TI-SPICE models.

(2) All t_r and t_f times are taken at the first receiver.

Switching Characteristics for UBT

over recommended operating conditions (unless otherwise noted) (see Figure 3)

(1) All typical values are at $V_{CC} = 3.3 V$, $T_A = 25^{\circ}C$. All values are derived from TI-SPICE models.

(2) All t_r and t_f times are taken at the first receiver.

Skew Characteristics for Bus Transceiver

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 3)

(1) All typical values are at $V_{CC} = 3.3 V$, $T_A = 25^{\circ}C$. All values are derived from TI-SPICE models.
(2) t_{other} – Output-to-output skew is defined as the absolute value of the difference between the ac

 $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) $[t_{sk(t)}]$.

Skew Characteristics for UBT

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 3)

(1) All typical values are at $V_{CC} = 3.3 V$, $T_A = 25^{\circ}C$. All values are derived from TI-SPICE models.
(2) t_{sk/th} – Output-to-output skew is defined as the absolute value of the difference between the ac

 $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) $[t_{sk(t)}]$.

Driver in Slot 1, With One Receiver in Slot 21 (Minimum Load)

Switching Characteristics for Bus Transceiver Function

over recommended operating conditions (unless otherwise noted) (see Figure 3)

Switching Characteristics for Bus Transceiver Function (continued)

over recommended operating conditions (unless otherwise noted) (see Figure 3)

(1) All typical values are at $V_{CC} = 3.3 V$, $T_A = 25^{\circ}C$. All values are derived from TI-SPICE models.

(2) All t_r and t_f times are taken at the first receiver.

Switching Characteristics for UBT

over recommended operating conditions (unless otherwise noted) (see Figure 3)

(1) All typical values are at $V_{CC} = 3.3$ V, $T_A = 25^{\circ}$ C. All values are derived from TI-SPICE models.

(2) All t_r and t_f times are taken at the first receiver.

Skew Characteristics for Bus Transceiver

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 3)

(1) All typical values are at $V_{CC} = 3.3 V$, $T_A = 25^{\circ}C$. All values are derived from TI-SPICE models.
(2) t_{sk(t)} – Output-to-output skew is defined as the absolute value of the difference between the act $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) $[t_{sk(t)}]$.

Skew Characteristics for UBT

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 3)

(1) All typical values are at $V_{CC} = 3.3 V$, $T_A = 25^{\circ}C$. All values are derived from TI-SPICE models.

(2) $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) $[t_{\text{sk}(t)}]$.

By simulating the performance of the device using the VME64x backplane (see Figure 3), the maximum peak current in or out of the B-port output, as the devices switch from one logic state to another, was found to be equivalent to driving the lumped load shown in Figure 4.

Figure 4. Equivalent AC Peak Output-Current Lumped Load

In general, the rise- and fall-time distribution is shown in Figure 5. Since VME devices were designed for use into distributed loads like the VME64x backplane (B/P), there are significant differences between low-to-high (LH) and high-to-low (HL) values in the lumped load shown in the PMI (see Figure 1 and Figure 2).

Characterization-laboratory data in Figure 6 and Figure 7 show the absolute ac peak output current, with different supply voltages, as the devices change output logic state. A typical nominal process is shown to demonstrate the devices' peak ac output drive capability.

TYPICAL CHARACTERISTICS

TYPICAL CHARACTERISTICS

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VMEbus Summary

In 1981, the VMEbus was introduced as a backplane bus architecture for industrial and commercial applications. The data-transfer protocols used to define the VMEbus came from the Motorola™ VERSA bus architecture that owed its heritage to the then recently introduced Motorola 68000 microprocessor. The VMEbus, when introduced, defined two basic data-transfer operations: single-cycle transfers consisting of an address and a data transfer, and a block transfer (BLT) consisting of an address and a sequence of data transfers. These transfers were asynchronous, using a master-slave handshake. The master puts address and data on the bus and waits for an acknowledgment. The selected slave either reads or writes data to or from the bus, then provides a data-acknowledge (DTACK*) signal. The VMEbus system data throughput was 40 Mbyte/s. Previous to the VMEbus, it was not uncommon for the backplane buses to require elaborate calculations to determine loading and drive current for interface design. This approach made designs difficult and caused compatibility problems among manufacturers. To make interface design easier and to ensure compatibility, the developers of the VMEbus architecture defined specific delays based on a 21-slot terminated backplane and mandated the use of certain high-current TTL drivers, receivers, and transceivers.

In 1989, multiplexing block transfer (MBLT) effectively increased the number of bits from 32 to 64, thereby doubling the transfer rate. In 1995, the number of handshake edges was reduced from four to two in the double-edge transfer (2eVME) protocol, doubling the data rate again. In 1997, the VMEbus International Trade Association (VITA) established a task group to specify a synchronous protocol to increase data-transfer rates to 320 Mbyte/s, or more. The unreleased specification, VITA 1.5 [double-edge source synchronous transfer (2eSST)], is based on the asynchronous 2eVME protocol. It does not wait for acknowledgement of the data by the receiver and requires incident-wave switching. Sustained data rates of 1 Gbyte/s, more than ten times faster than traditional VME64 backplanes, are possible by taking advantage of 2eSST and the 21-slot VME320 star-configuration backplane. The VME320 backplane approximates a lumped load, allowing substantially higher-frequency operation over the VME64x distributed-load backplane. Traditional VME64 backplanes with no changes theoretically can sustain 320 Mbyte/s.

From BLT to 2eSST – A Look at the Evolution of VMEbus Protocols by John Rynearson, Technical Director, VITA, provides additional information on VMEbus and can be obtained at www.vita.com.

Maximum Data Transfer Rates

Applicability

Target applications for VME backplanes include industrial controls, telecommunications, simulation, high-energy physics, office automation, and instrumentation systems.

PACKAGING INFORMATION

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74VMEH22501A :

• Enhanced Product: SN74VMEH22501A-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TEXAS
INSTRUMENTS

TAPE DIMENSIONS

TAPE AND REEL INFORMATION

*All dimensions are nominal

TEXAS
INSTRUMENTS

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

ZQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY

NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-285 variation BA-2.
- D. This package is Pb-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).

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MECHANICAL DATA

MPDS006C – FEBRUARY 1996 – REVISED AUGUST 2000

DGV (R-PDSO-G) PLASTIC SMALL-OUTLINE**

24 PINS SHOWN

NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194

GQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY

NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

- C. Falls within JEDEC MO-285 variation BA-2.
- D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.

MECHANICAL DATA

MTSS003D – JANUARY 1995 – REVISED JANUARY 1998

DGG (R-PDSO-G) PLASTIC SMALL-OUTLINE PACKAGE**

48 PINS SHOWN

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153

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